

# Thermal modelling of terahertz quantum-cascade lasers

C. A. Evans\*, D. Indjin, Z. Ikonjić, and P. Harrison

Institute of Microwaves and Photonics, School of Electronic & Electrical Engineering, University of Leeds, LS2 9JT, U.K. (\*c.a.evans@leeds.ac.uk)

M. S. Vitiello and G. Scamarcio

CNR-INFM Regional Laboratory LIT3 and Dipartimento Interateneo di Fisica "M. Merlin", Università degli Studi di Bari, Via Amendola 173, 70126 Bari, Italy

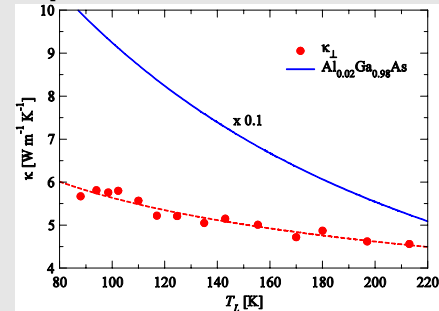
V. Spagnolo

CNR-INFM Regional Laboratory LIT3 and Dipartimento Interateneo di Fisica "M. Merlin", Politecnico di Bari, Via Amendola 173, 70126 Bari, Italy

## Introduction

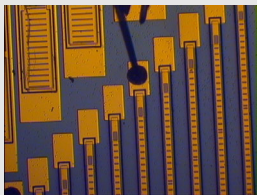
- The thermal properties of THz QCLs play a crucial role in determining the device performance.
- THz QCLs have inferior temperature performance compared to MIR devices due to the difficulty in achieving selective injection and depopulation of the upper and lower laser levels at higher temperatures.
- Additionally, since the photon energy is less than the LO phonon energy, at high temperatures, thermally activated LO phonon emission can seriously reduce the upper laser level lifetime.
- Coupled with these facts, the cross-plane thermal conductivity of QCL active regions is reduced compared to bulk due to their multilayer nature and makes heat extraction from the active region difficult.
- THz QCLs particularly suffer due to the large active region thickness and increased number of interfaces which increases the thermal resistance.
- The optical waveguide configuration also plays an important role in determining the thermal properties of the device.

## Cross-plane Thermal Conductivity



- Temperature dependent cross-plane thermal conductivity extracted by fitting simulations to measured data –  $k = 21.207 \cdot T_L^{-0.288}$  W/(m K).
- Good agreement with measured values of GaAs/AlAs superlattices [3].
- Decreasing function of temperature could be limiting factor in the temperature performance of all GaAs-based QCLs?

## Theory and Experiment

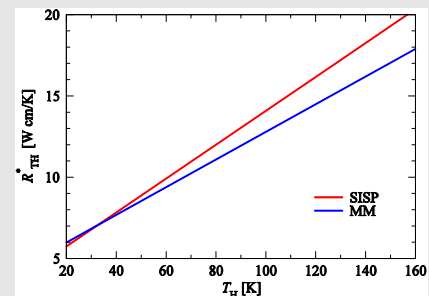


- Investigated the thermal properties of a surface-emitting THz QCL with metal-metal (MM) optical waveguide.
- Local-lattice temperature measured on top of the device active region using a microprobe band-to-band PL technique [1].
- Calibration curves obtained at 'device-off' by measuring PL while varying  $T_H$ .
- Comparing the shift of the main PL peak with the calibration curves allows the lattice temperature to be extracted.

- Heat flow simulated using steady-state two- and three-dimensional anisotropic thermal models.
- Solved using a finite-difference method and successive over-relaxation technique.
- Model takes in account temperature and doping dependent thermal conductivities.

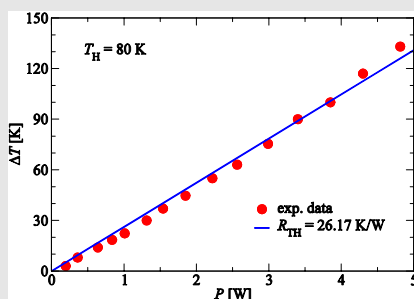
$$\nabla \cdot [k \nabla T] + Q = 0$$

## Comparison of Optical Waveguides



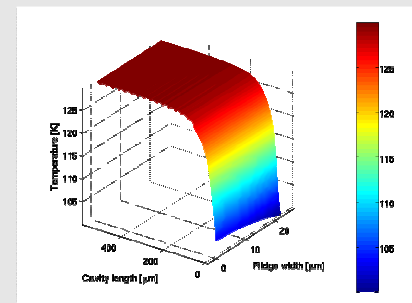
- Normalised ( $R^* = R \times S/d$ ) thermal resistances of MM and semi-insulating surface-plasmon (SISP) optical waveguides simulated.
- At low heat sink temperatures, SISP waveguides have smaller  $R_{TH}$  due to higher thermal conductivity of the SI substrate.
- MM waveguides get progressively better at higher values of  $T_H$ .

## Device Thermal Resistance



- Lattice temperature rise measured in central aperture of DFB at a heat sink temperature of  $T_H = 80$  K for a range of electrical powers\*.
- Linear fit to data gives rise to a thermal resistance of 26.17 K/W.
- Similar to previously extracted values of thermal resistance for edge-emitting THz QCLs with MM optical waveguides [2].

## Longitudinal Temperature Distribution



- Longitudinal temperature distribution simulated at  $P = 2.1$  W.
- Insulator/metal covered facets open up longitudinal heat flow channels.
- Suggests electroplated Gold on sidewalls could improve temperature performance although this will depend on the ridge aspect ratio.

## References

- [1] V. Spagnolo et al., *Appl. Phys. Lett.*, vol. 15, no. 15, p. 2095, 2001.
  - [2] M. S. Vitiello et al., *Appl. Phys. Lett.*, vol. 86, no. 021111, p. 1, 2006.
  - [3] W. S. Capinski et al., *Phys. Rev. B*, vol. 59, pp. 8105-8113, 1999.
- \* Experimental data taken from G. Scamarcio, M. S. Vitiello, V. Spagnolo, S. Kumar, B. S. Williams, and Q. Hu, accepted for publication in *Physica E*, 2007.